

EMIF04-MMC02F3

4 LINES EMI FILTER AND ESD PROTECTION FOR MULTIMEDIA CARD

Main product characteristics:

Where EMI filtering in ESD sensitive equipment is required:

MultiMedia Card for mobile phones, Personal Digital Assistant, Digital Camera, MP3 players...

Description

The EMIF04-MMC02F3 is a highly integrated device designed to suppress EMI/RFI noise for MultiMedia Card ports. The EMIF04 Flip-Chip packaging means the package size is equal to the die size.

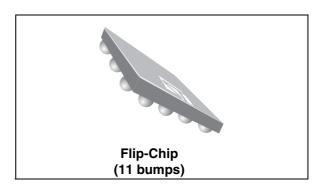
This filter includes ESD protection circuitry which prevents damage to the application when subjected to ESD surges up to 15kV.

Benefits

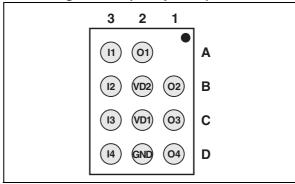
- EMI symmetrical (I/O) low-pass filter
- High efficiency in EMI filtering
- Lead free package
- 400µm pitch
- Compatible with high speed data rate
- Very low PCB space consuming: < 2 mm²
- Very thin package: 0.60 mm
- High efficiency in ESD suppression
- High reliability offered by monolithic integration
- High reducing of parasitic elements through integration and wafer level packaging

Complies with the following standards: IEC61000-4-2:

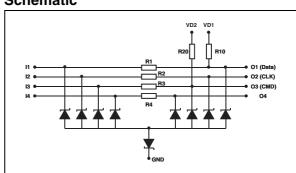
Level 4 15kV (air discharge) 8kV (contact discharge)



Pin configuration (bump side)



Schematic



Order codes

Part number	Marking
EMIF04-MMC02F3	GP

Rev 1 June 2005 1/9

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Table 1. Absolute maximum rating (limiting values)

Symbol	Parameter	Value	Unit
V _{PP}	ESD discharge IEC61000-4-2, air discharge ESD discharge IEC61000-4-2, contact discharge	15 8	kV
Tj	Junction temperature	125	°C
T _{op}	Operating temperature range	-40 to + 85	°C
T _{stg}	Storage temperature range	-55 to +150	°C

1 ELECTRICAL CHARACTERISTICS (T_{amb} = 25°C)

Symbol	Parameter	<u> </u>	1 1
V_{BR}	Breakdown voltage		
I _{RM}	Leakage current		
V_{RM}	Stand-off voltage	V _{CL} V _{BR} V _{RM}	
V _{CL}	Clamping voltage	CL BR RM	I _{RM}
I _{PP}	Peak pulse current		I _R
R _{I/O}	Series resistance between Input & Output		l _{pp}
Cline	Input capacitance per line		

Symbol	Test conditions	Min.	Тур.	Max.	Unit
V _{BR}	I _R = 1 mA	6			V
I _{RM}	V _{RM} = +3V		100	250	nA
Cline	$V_{LINE} = 0 \text{ V}, V_{OSC} = 30 \text{ mV}, F = 1 \text{MHz}$			20	pF
R ₁ , R ₂ , R ₃ , R ₄	Tolerance ± 10%		47		Ω
R ₁₀	Tolerance ± 10%		13		kΩ
R ₂₀	Tolerance ± 10%		56		kΩ

Figure 1. S21 attentuation measurements A2 - A3 line

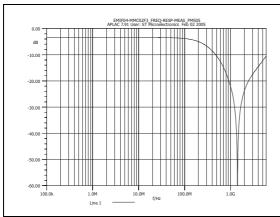


Figure 2. S21 attentuation measurements B1 -B3 line

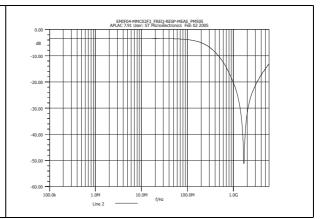


Figure 3. S21 attentuation measurements C1 - C3 line

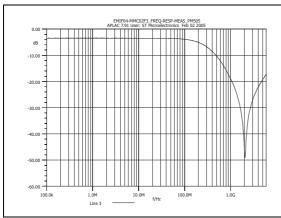


Figure 4. S21 attentuation measurements D1 - D3 line

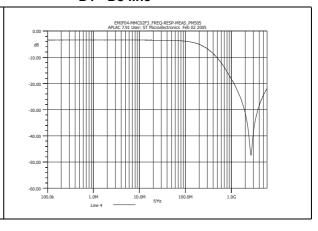


Figure 5. Crosstalk behaviour (A2 - B3 line)

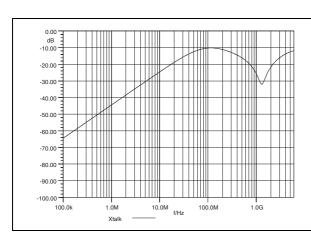
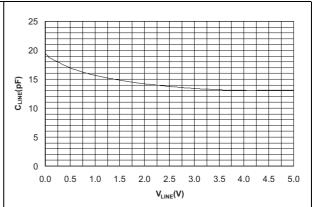


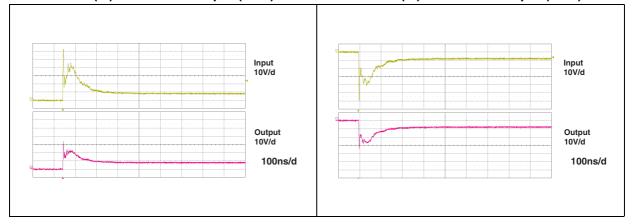
Figure 6. Line capacitance versus reverse applied voltage



2 Aplac model EMIF04-MMC02F3

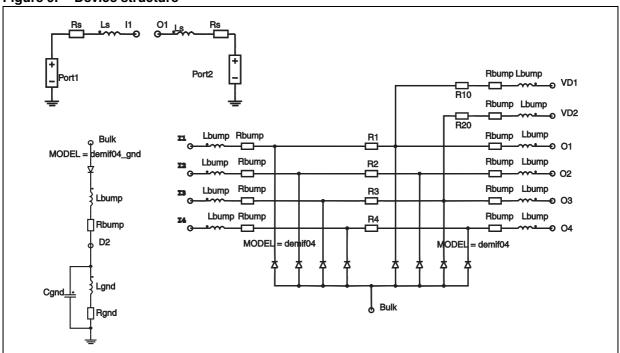
Figure 7. ESD response to IEC61000-4-2 (+15kV air discharge) on one input V(in) and on one output (Vout).

Figure 8. ESD response to IEC61000-4-2 (-15kV air discharge) on one input V(in) and on one output (Vout)



2 Aplac model

Figure 9. Device structure

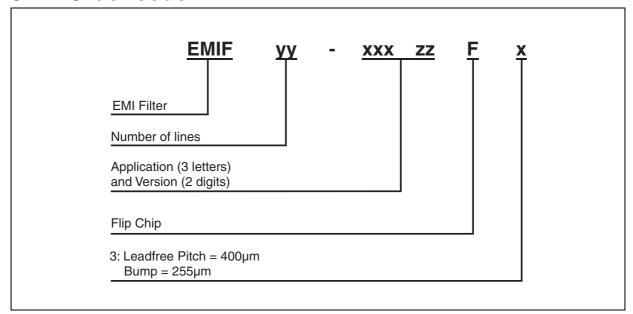


3 Order code EMIF04-MMC02F3

Figure 10. Aplac model variables

aplacvar R1 47 aplacvar R2 47 aplacvar R3 47 aplacvar R4 47 aplacvar R10 13k Diode Demif04 Diode Demif04_gnd aplacvar R20 56k BV=7 BV=7 aplacvar Rsub 120m IBV=1m IBV=1m aplacvar Cz 16.65pF CJO=Cz CJO=Cz_gnd aplacvar Cz_gnd 49.95pF M = 0.31M=0.31 aplacvar RS_gnd 480m RS=1 RS=RS_gnd aplacvar Ls 950pH VJ=0.6 VJ=0.6 aplacvar Rs 150m TT=100n TT=100n aplacvar Rbump 20m aplacvar Lbump 50pH aplacvar Lgnd 250pH aplacvar Rgnd 200m aplacvar Cgnd 0.6pF

3 Order code



4 Package information EMIF04-MMC02F3

4 Package information

Figure 11. Mechanical data

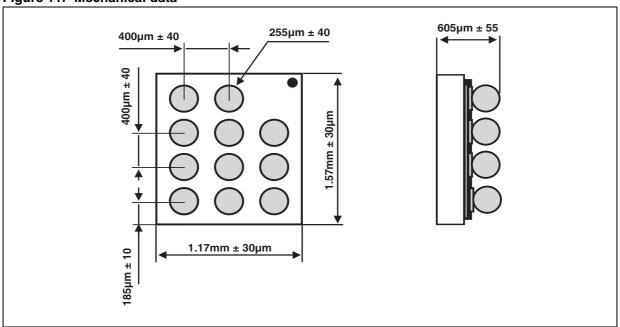
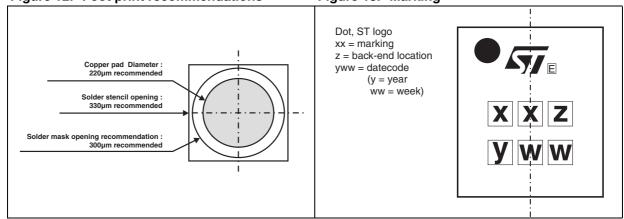
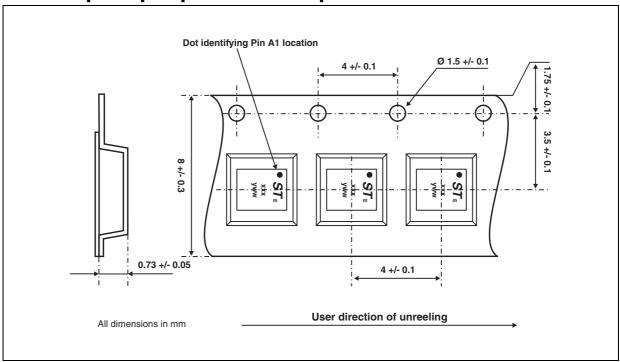


Figure 12. Foot print recommendations Figure 13. Marking



5 Flip-chip tape and reel specification



6 Ordering information

Part Number	Marking	Package	Weight	Base qty	Delivery mode
EMIF04-MMC02F3	GP	Flip-Chip	2.4 mg	5000	Tape and reel 7"

Note: More information is available in the application notes:

- AN1235: "Flip-Chip: Package description and recommandations for use"
- AN1751: "EMI Filters: Recommendations and measurements"

7 Revision history EMIF04-MMC02F3

7 Revision history

Date	Revision	Description of Changes
16-Jun-2005	1	First issue



7 Revision history EMIF04-MMC02F3

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